

A 12 V, 18 m Ω , 5 A Integrated Power Switch with VIN Lockout Select and MOSFET Current Monitor Output

General Description

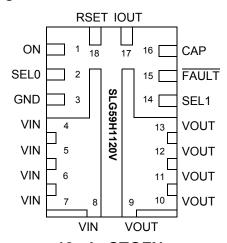
The SLG59H1120V is a high-performance, self-powered 18 m Ω NMOS power switch designed for all 4.5 to 12 V power rails up to 5A. Using a proprietary MOSFET design, the SLG59H1120V achieves a stable 18 m Ω RDSON across a wide input/supply voltage range and over temperature. Using Silego's proprietary CuFETTM technology, the SLG59H1120V package also exhibits a low thermal resistance for high-current operation.

Designed to operate over a -40°C to 85°C range, the SLG59H1120V is available in a low thermal resistance, RoHS-compliant, 1.6 x 3.0 mm STQFN package.

Features

- Wide Operating Supply Voltage: 4.5 V to 13.2 V
- · Maximum Continuous Switch Current: 5 A
- · Automatic nFET SOA Protection
- High-performance MOSFET Switch Low RDSON: 18 mΩ at V_{IN} = 12 V Low ΔRDSON/ΔVIN: <0.05 mΩ/V Low ΔRDSON/ΔT: <0.06 mΩ/°C
- · 3-Level, Pin-selectable VIN Overvoltage Lockout
- · Capacitor-programmable Inrush Current Control
- Two stage Current Limit Protection:
 Resistor-programmable Active Current Limit
 Internal Short-circuit Current limit
- Open Drain FAULT Signaling
- MOSFET Current Analog Output Monitor: 10 μA/A
- Fast 4 kΩ Output Discharge
- · Pb-Free / Halogen-Free / RoHS Compliant Packaging

Pin Configuration

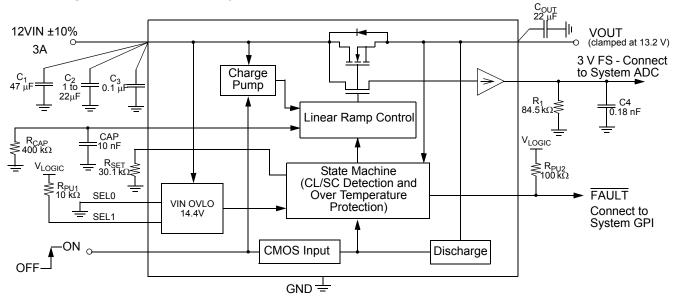


18-pin STQFN 1.6 x 3.0 mm, 0.40mm pitch (Top View)

Applications

- Enterprise Computing & Telecom Equipment 5V and 12V Point-of-Load Power Distribution
- PCI/PCIe Adapter Cards
- · General-purpose High-voltage, Power-Rail Switching
- · Multifunction Printers
- Fan Motor Control

Block Diagram and a 12V / 3 A Typical Application Circuit





Pin Description

Pin#	Pin Name	Туре	Pin Description
1	ON	Input	A low-to-high transition on this pin initiates the operation of the SLG59H1120V's state machine. ON is an asserted HIGH, level-sensitive CMOS input with VIL < 0.3 V and VIH > 0.9 V. As the ON pin input circuit does not have an internal pull-down resistor, connect this pin to a general-purpose output (GPO) of a microcontroller, an application processor, or a system controller – do not allow this pin to be open-circuited.
2	SEL0	Input	As level-sensitive, CMOS inputs with VIL < 0.3 V and VIH > 1.65 V, the SEL0 (LSB) and the SEL1 (MSB) pins select one of four VIN overvoltage lockout thresholds. Please see the Applications Section for additional information and the Electrical Characteristics table for the VIN overvoltage thresholds. A logic LOW on either pin is achieved by connecting the pin of interest to GND; a logic HIGH on either pin is achieved by connecting a 10 k Ω external resistor from the pin in question to the system's local logic supply.
3	GND	GND	Pin 3 is the main ground connection for the SLG59H1120V's internal charge pump, its gate drive and current-limit circuits as well as its internal state machine. Therefore, use a short, stout connection from Pin 3 to the system's analog or power plane.
4-8	VIN	MOSFET	VIN supplies the power for the operation of the SLG59H1120V, its internal control circuitry, and the drain terminal of the nFET power switch. With 5 pins fused together at VIN, connect a 47 μ F (or larger) low-ESR capacitor from this pin to ground. Capacitors used at VIN should be rated at 50 V or higher.
9-13	VOUT	MOSFET	Source terminal of n-channel MOSFET (5 pins fused for VOUT). Connect a 22 μ F (or larger) low-ESR capacitor from this pin to ground. Capacitors used at VOUT should be rated at 50 V or higher.
14	SEL1	Input	Please see SEL0 Pin Description above
15	FAULT	Output	An open drain output, \overline{FAULT} is asserted within \overline{TFAULT}_{LOW} when a VIN overvoltage, a current-limit, a \underline{nFET} SOA, or an over-temperature condition is detected. FAULT is deasserted within \overline{TFAULT}_{HIGH} when the fault condition is removed. Connect an 100 k Ω external resistor from the FAULT pin to local system logic supply.
16	CAP	Output	A low-ESR, stable dielectric, ceramic surface-mount capacitor connected from CAP pin to GND sets the VOUT slew rate and overall turn-on time of the SLG59H1120V. For best performance, the range for CAP values are 10 nF \leq CAP \leq 20 nF $-$ please see typical characteristics for additional information. Capacitors used at the CAP pin should be rated at 10 V or higher. Please consult Applications Section on how to select CAP based on VOUT slew rate and loading conditions.
17	IOUT	Output	IOUT is the SLG59H1120V's power MOSFET load current monitor output. As an analog output current, this signal when applied to a ground-reference resistor generates a voltage proportional to the current through the n-channel MOSFET. The IOUT transfer characteristic is typically 10 μ A/A with a voltage compliance range of 0.5 V \leq V(IOUT) \leq 4V. Optimal IOUT linearity is exhibited for 0.5 A \leq IDS \leq 5 A. In addition, it is recommended to bypass the IOUT pin to GND with a 0.18 nF capacitor.
18	RSET	Input	A 1%-tolerance, metal-film resistor between 18 k Ω and 95 k Ω sets the SLG59H1120V's active current limit. A 95 k Ω resistor sets the SLG59H1120V's active current limit to 1 A and a 18 k Ω resistor sets the active current limit to 5 A.

Ordering Information

ĺ	Part Number	Туре	Production Flow
	SLG59H1120V	STQFN 18L FC	Industrial, -40 °C to 85 °C
Ī	SLG59H1120VTR	STQFN 18L FC (Tape and Reel)	Industrial, -40 °C to 85 °C

000-0059H1120-101 Page 2 of 19



Absolute Maximum Ratings

Parameter	Description	Conditions	Min.	Тур.	Max.	Unit
		Continuous	-0.3		16	V
VIN to GND	Power Switch Input Voltage to GND	Maximum pulsed VIN, pulse width <0.1s			18	V
VOUT to GND	Power Switch Output Voltage to GND		-0.3		VIN	V
ON, SEL[1,0], CAP, R <u>SET, IO</u> UT, and FAULT to GND	ON, SEL[1,0], CAP, RSET, IOUT, and FAULT Pin Voltages to GND		-0.3		7	V
T _S	Storage Temperature		-65		150	°C
ESD _{HBM}	ESD Protection	Human Body Model	2000			V
ESD _{CDM}	ESD Protection	Charged Device Model	500			V
MSL	Moisture Sensitivity Level			1		
Θ_{JA}	Thermal Resistance	1.6 x 3.0 mm 18L STQFN; Determined with the device mounted onto a 1 in ² , 1 oz. copper pad of FR-4 material		40		°C/W
MOSFET IDS _{CONT}	Continuous Current from VIN to VOUT	T _J < 150°C			5	Α
MOSFET IDS _{PEAK}	Peak Current from VIN to VOUT	Maximum pulsed switch current, pulse width < 1 ms			6	Α

Note: Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

Electrical Characteristics

 $4.5~V \le V_{IN} \le 13.2~V$; CIN = 47 μ F, T_A = -40°C to 85° C, unless otherwise noted. Typical values are at T_A = 25° C

Parameter	Description	Conditions	Min.	Тур.	Max.	Unit
V _{IN}	Operating Input Voltage		4.5		13.2	V
		V _{IN} ↑; SEL[1,0] = [0,0]	5.6	6	6.3	V
$V_{IN(OVLO)}$	VIN Overvoltage Lockout Threshold	V _{IN} ↑; SEL[1,0] = [0,1]	10.2	10.8	11.4	V
		V _{IN} ↑; SEL[1,0] = [1,0]	13.5	14.4	15.2	V
V _{IN(UVLO)}	VIN Undervoltage Lockout Threshold	V _{IN} ↓	2.4		3.8	V
IQ	Quiescent Supply Current	ON = HIGH; I _{DS} = 0 A		0.5	0.6	mA
I _{SHDN}	OFF Mode Supply Current	ON = LOW; I _{DS} = 0 A		1	3	μA
RDS _{ON}	Static Drain to Source ON Resistance	T _A = 25°C; I _{DS} = 0.1 A		18	20	mΩ
KDSON	Static Drain to Source ON Nesistance	T _A = 85°C; I _{DS} = 0.1 A		22	24	mΩ
1	Active Current Limit, I _{ACL}	$V_{OUT} > 0.5 \text{ V; R}_{SET} = 30.1 \text{ k}\Omega$	2.8	3.2	3.6	Α
I _{LIMIT}	Short-circuit Current Limit, I _{SCL}	V _{OUT} < 0.5 V		0.5		Α
T _{ACL}	Active Current Limit Response Time			120		μs
R _{DSCHRG}	Output Discharge Resistance		3.5	4.4	5.3	kΩ

O00-0059H1120-101 Page 3 of 19



Electrical Characteristics (continued)

 $4.5 \text{ V} \le \text{V}_{\text{IN}} \le 13.2 \text{ V}$; CIN = 47 μF , T_{A} = -40°C to 85°C, unless otherwise noted. Typical values are at T_{A} = 25°C

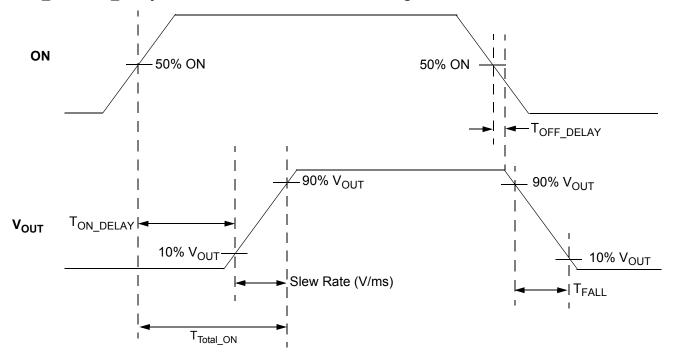
Parameter	Description	Conditions	Min.	Тур.	Max.	Unit
	MOSFET Current Analog Monitor Out-	I _{LOAD} = 1 A	9.3	10	10.7	μA
IOUT put		I _{LOAD} = 3 A	28.5	30	31.5	μA
T _{IOUT}	I _{OUT} Response Time to Change in Main MOSFET Current	C _{IOUT} = 180 pF; Step load 0 to 2.4 A; 0% to 90% I _{OUT}		45		μs
CAP _{OUT}	Output Capacitive Load to GND		22			μF
т.	ON Delay Time	50% ON to 10% V_{OUT} ↑; V_{IN} = 4.5 V; CAP = 10 nF; R_{LOAD} = 100 Ω, C_{LOAD} = 10 μF		0.3	0.5	ms
T _{ON_Delay}	ON Delay Time	50% ON to 10% $V_{OUT} \uparrow$; V_{IN} = 12 V; CAP = 10 nF; R_{LOAD} = 100 Ω , C_{LOAD} = 10 μ F		0.7	1.2	ms
		50% ON to 90% V _{OUT} ↑	Set b	y External	CAP ¹	ms
T _{Total_ON}	Total Turn-on Time	50% ON to 90% V_{OUT} ↑; V_{IN} = 4.5 V; CAP = 10 nF; R_{LOAD} = 100 Ω , C_{LOAD} = 10 μ F		1.4	2.1	ms
		50% ON to 90% V_{OUT} ↑; V_{IN} = 12 V; CAP = 10 nF; R_{LOAD} = 100 Ω, C_{LOAD} = 10 μF		5	8	ms
		10% V _{OUT} to 90% V _{OUT} ↑	Set by External CAP ¹			V/ms
V _{OUT(SR)}	VOUT Slew rate	10% V_{OUT} to 90% V_{OUT} ↑; V_{IN} = 4.5 to 12 V; CAP = 10 nF; R_{LOAD} = 100 Ω, C_{LOAD} = 10 μF	2.7	3.2	3.9	V/ms
T _{OFF_Delay}	OFF Delay Time	50% ON to $V_{OUT} \downarrow$; R _{LOAD} = 100 Ω , No C _{LOAD}		15		μs
T _{Fall}	VOUT Fall Time	ON = HIGH-to-LOW; R _{LOAD} = 100 Ω , No C _{LOAD}	10.4	12.7	14.3	μs
TFAULT _{LOW}	FAULT Assertion Time	Current-limit Detection to FAULT \downarrow ; I_{ACL} = 1 A; V_{IN} = 12 V; R_{SET} = 90 k Ω ; switch in 20 Ω load		80		μs
TFAULT _{HIGH}	FAULT De-assertion Time	Delay to FAULT \uparrow after fault condition is removed; I _{ACL} = 1 A; V _{IN} = 12 V; R _{SET} = 90 k Ω ; switch out 20 Ω load		180		μs
FAULT	FAULT Output Low Voltage	I _{FAULT} = 1 mA		0.2		V
ON_VIH	ON Pin Input High Voltage		0.9		5	V
ON_VIL	ON Pin Input Low Voltage		-0.3	0	0.3	V
SEL[1,0]_VIH	SEL[1,0] pins Input High Voltage		1.65		4.5	V
SEL[1,0]_VIL	SEL[1,0] pins Input Low Voltage		-0.3		0.3	V
I _{ON(Leakage)}	ON Pin Leakage Current	1V ≤ ON ≤ 5V or ON = GND			1	μΑ
THERMON	Thermal Protection Shutdown Threshold			125		°C
THERMOFF	Thermal Protection Restart Threshold			100		°C

1. Refer to typical Timing Parameter vs. CAP performance charts for additional information when available.

000-0059H1120-101 Page 4 of 19



TTotal_ON, TON_Delay and Slew Rate Measurement Timing Details

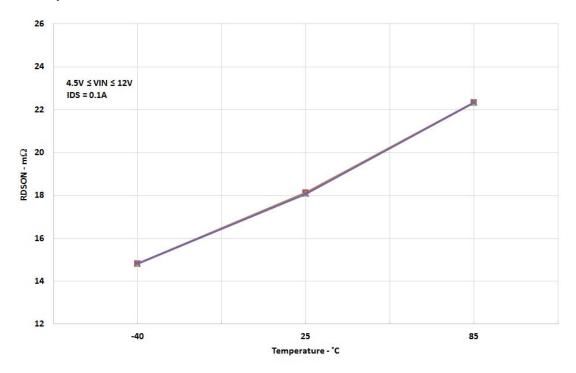


000-0059H1120-101 Page 5 of 19

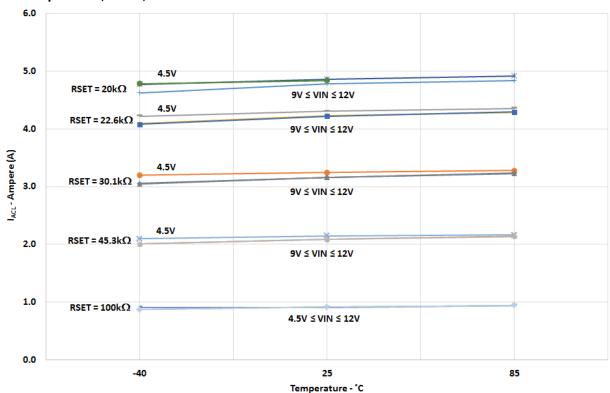


Typical Performance Characteristics

RDSON vs. Temperature and VIN



 $I_{\mbox{\scriptsize ACL}}$ vs. Temperature, RSET, and VIN

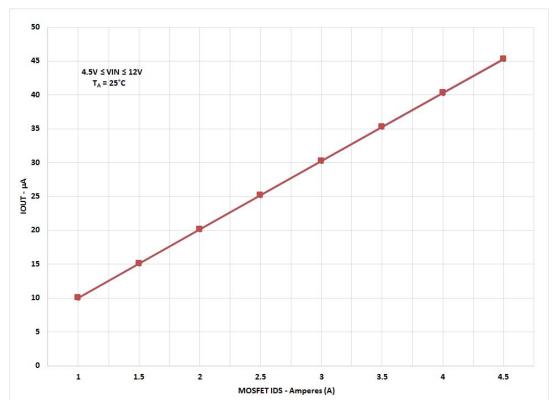


000-0059H1120-101 Page 6 of 19

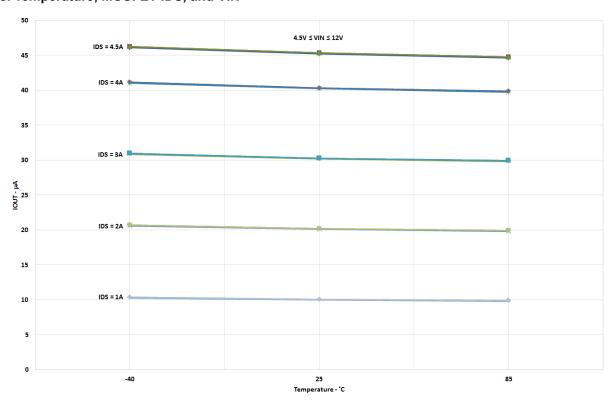




IOUT vs. MOSFET IDS and VIN



IOUT vs. Temperature, MOSFET IDS, and VIN

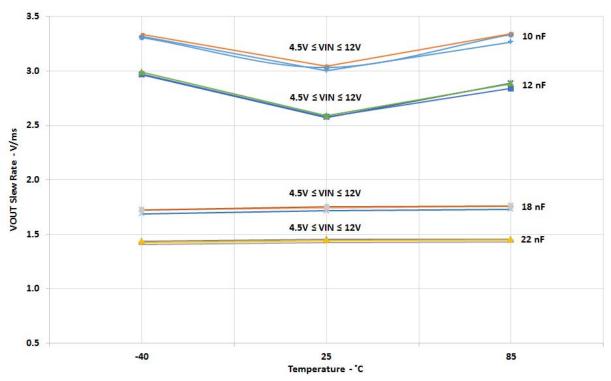


000-0059H1120-101 Page 7 of 19

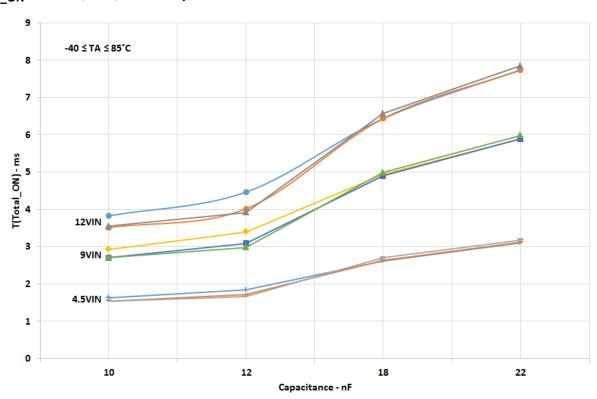




VOUT Slew Rate vs. Temperature, VIN, and CAP



 T_{Total_ON} vs. CAP, VIN, and Temperature

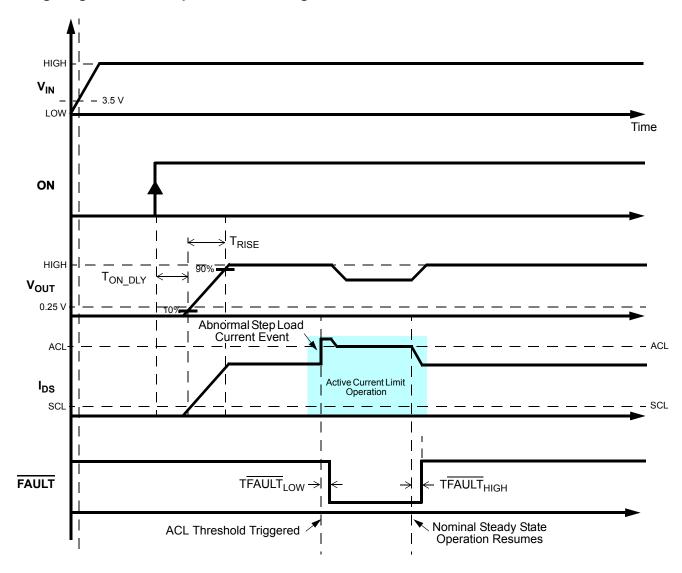


000-0059H1120-101 Page 8 of 19





Timing Diagram - Basic Operation including Active Current Limit Protection

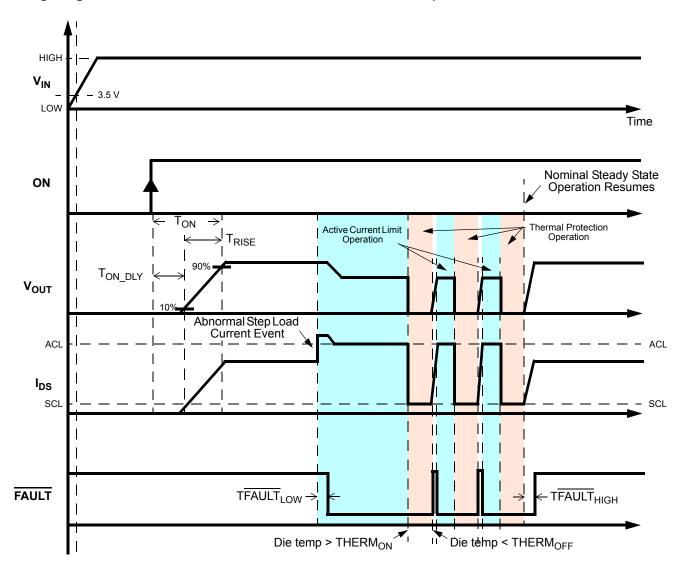


000-0059H1120-101 Page 9 of 19





Timing Diagram - Active Current Limit & Thermal Protection Operation

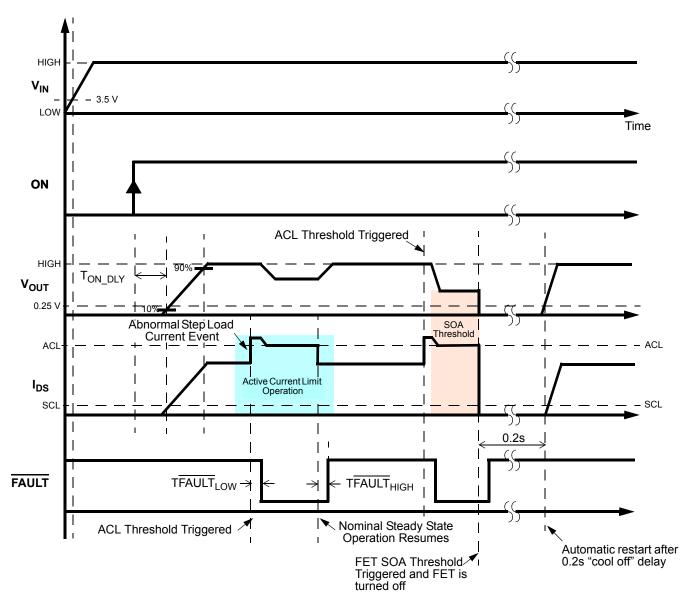


000-0059H1120-101 Page 10 of 19





Timing Diagram - Basic Operation including Active Current + Internal FET SOA Protection



000-0059H1120-101 Page 11 of 19



Applications Information

HFET1 Safe Operating Area Explained

Silego's HFET1 integrated power controllers incorporate a number of internal protection features that prevents them from damaging themselves or any other circuit or subcircuit downstream of them. One particular protection feature is their Safe Operation Area (SOA) protection. SOA protection is automatically activated under overpower and, in some cases, under overcurrent conditions. Overpower SOA is activated if package power dissipation exceeds an internal 5W threshold longer than 2.5 ms. HFET1 devices will quickly switch off (open circuit) upon overpower detection and automatically resume (close) nominal operation once overpower condition no longer exists.

One possible way to have an overpower condition trigger SOA protection is when HFET1 products are enabled into heavy output resistive loads and/or into large load capacitors. It is under these conditions to follow carefully the "Safe Start-up Loading" guidance in the Applications section of the datasheet. During an overcurrent condition, HFET1 devices will try to limit the output current to the level set by the external RSET resistor. Limiting the output current, however, causes an increased voltage drop across the FET's channel because the FET's RDS_{ON} increased as well. Since the FET's RDS_{ON} is larger, package power dissipation also increases. If the resultant increase in package power dissipation is higher/equal than 5 W for longer than 2.5 ms, internal SOA protection will be triggered and the FET will open circuit (switch off). Every time SOA protection is triggered, all HFET1 devices will automatically attempt to resume nominal operation after 160 ms.

Safe Start-up Condition

SLG59H1120V has built-in protection to prevent over-heating during start-up into a heavy load. Overloading the VOUT pin with a capacitor and a resistor may result in non-monotonic VOUT ramping. In general, under light loading on VOUT, VOUT ramping can be controlled with C_{SLEW} value. The following equation serves as a guide:

$$C_{SLEW} = \frac{T_{RAMP}}{V_{IN}} \times 4.9 \,\mu\text{A} \times \frac{20}{3}$$

where

 T_{RAMP} = Total ramping time for V_{OUT} to reach V_{IN}

V_{IN} = Input Voltage

C_{SI FW} = Capacitor value for CAP pin

When capacitor and resistor loading on VOUT during start up, the following tables will ensure VOUT ramping is monotonic without triggering internal protection:

	Safe Start-up Loading for V _{IN} = 12 V (Monotonic Ramp)									
Slew Rate (V/ms) C_{SLEW} Control (nF) ³ C_{LOAD} (μ F) R_{LOAD} (Ω)										
1	33.3	500	20							
2	16.7	250	20							
3	11.1	160	20							
4	8.3	120	20							
5	6.7	100	20							

Note 3: Select the closest-value tolerance capacitor.

000-0059H1120-101 Page 12 of 19



Setting the SLG59H1120V's Active Current Limit

RSET (kΩ)	Active Current Limit (A)
95	1
45	2
30	3
18	5

Setting the SLG59H1120V's Input Overvoltage Lockout Threshold

As shown in the table below, SEL[1,0] selects the VIN overvoltage threshold at which the SLG59H1120V's internal state machine will turn OFF (open circuit) the power MOSFET if VIN exceeds the selected threshold.

SEL1	SEL0	VIN OVLO (Typ)
0	0	6 V
0	1	10.8 V
1	0	14.4 V
1	1	Reserved

With an activated SLG59H1120V (ON=HIGH) and at any time VIN crosses the programmed VIN overvoltage threshold, the state machine opens the power switch and asserts the FAULT pin within TFAULT DOW.

In applications with a deactivated or inactive SLG59H1120V (VIN > VIN_{UVLO} and ON=LOW) and if the applied VIN is higher than the programmed VIN OVLO threshold, the SLG59H1120V's state machine will keep the <u>power</u> switch open circuited if the ON pin is toggled LOW-to-HIGH. In these cases, the FAULT pin will also be asserted within TFAULT_{LOW} and will remain asserted until VIN resumes nominal, steady-state operation.

In all cases, the SLG59H1120V's VIN undervoltage lockout threshold is fixed at V_{IN(UVLO)}.

Power Dissipation

The junction temperature of the SLG59H1120V depends on different factors such as board layout, ambient temperature, and other environmental factors. The primary contributor to the increase in the junction temperature of the SLG59H1120V is the power dissipation of its power MOSFET. Its power dissipation and the junction temperature in nominal operating mode can be calculated using the following equations:

$$PD = RDS_{ON} \times I_{OUT}^2$$

where:

PD = Power dissipation, in Watts (W) $RDS_{ON} = Power \; MOSFET \; ON \; resistance, \; in \; Ohms \; (\Omega)$ $I_{OUT} = Output \; current, \; in \; Amps \; (A)$ and

$$T_{J} = PD \times \Theta_{JA} + T_{A}$$

where:

 T_J = Junction temperature, in Celsius degrees (°C) Θ_{JA} = Package thermal resistance, in Celsius degrees per Watt (°C/W) T_A = Ambient temperature, in Celsius degrees (°C)

000-0059H1120-101 Page 13 of 19



Power Dissipation (continued)

In current-limit mode, the SLG59H1120V's power dissipation can be calculated by taking into account the voltage drop across the power switch (VIN-VOUT) and the magnitude of the output current in current-limit mode (I_{ACL}):

$$PD = (V_{IN} - V_{OUT}) \times I_{ACL} \text{ or}$$

$$PD = (V_{IN} - (R_{LOAD} \times I_{ACL})) \times I_{ACL}$$

where:

PD = Power dissipation, in Watts (W) V_{IN} = Input Voltage, in Volts (V) R_{LOAD} = Load Resistance, in Ohms (Ω) I_{ACL} = Output limited current, in Amps (A) V_{OUT} = R_{LOAD} x I_{OCL}

000-0059H1120-101 Page 14 of 19





Package Top Marking System Definition



1120V - Part ID Field WW - Date Code Field¹ NNN - Lot Traceability Code Field¹ A - Assembly Site Code Field² RR - Part Revision Code Field²

Note 1: Each character in code field can be alphanumeric A-Z and 0-9

Note 2: Character in code field can be alphabetic A-Z

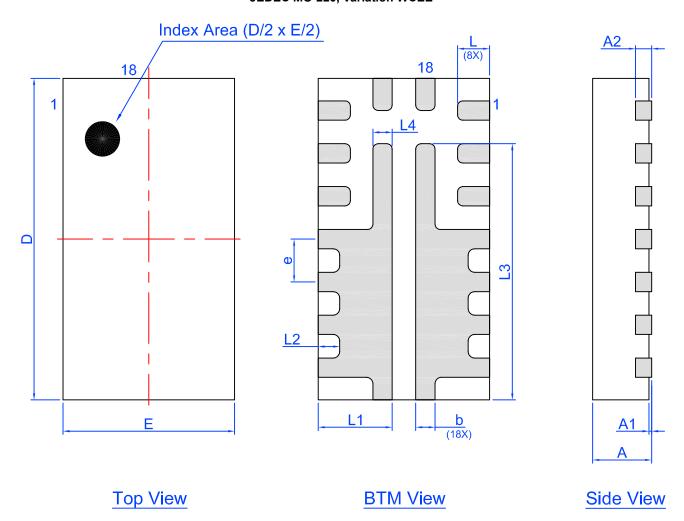
000-0059H1120-101 Page 15 of 19





Package Drawing and Dimensions

18 Lead TQFN Package 1.6 x 3 mm (Fused Lead) JEDEC MO-220, Variation WCEE



Unit: mm

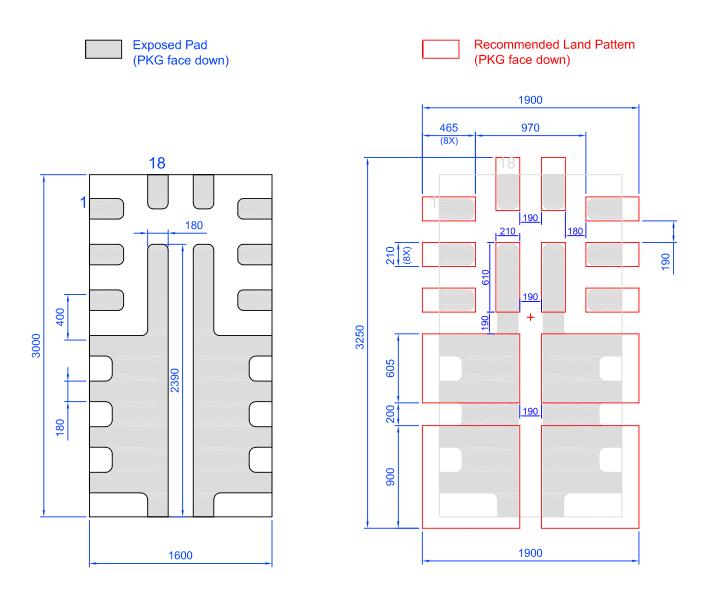
Symbol	Min	Nom.	Max	Symbol	Min	Nom.	Max
Α	0.50	0.55	0.60	D	2.95	3.00	3.05
A1	0.005	-	0.05	E	1.55	1.60	1.65
A2	0.10	0.15	0.20	L	0.25	0.30	0.35
b	0.13	0.18	0.23	L1	0.64	0.69	0.74
е	(0.40 BSC	,	L2	0.15	0.20	0.25
L3	2.34	2.39	2.44	L4	0.13	0.18	0.23

000-0059H1120-101 Page 16 of 19





SLG59H1120V 18-pin STQFN PCB Landing Pattern



Note: All dimensions shown in micrometers (µm)

000-0059H1120-101 Page 17 of 19

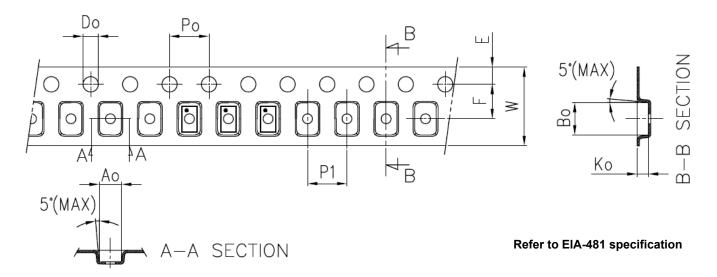


Tape and Reel Specifications

Dookogo	# of	Nominal	Max	Units	Reel &	Leade	r (min)	Trailer	(min)	Tape	Part
Package Type	# OI Pins	Package Size [mm]	per Reel	per Box	Hub Size [mm]	Pockets	Length [mm]	Pockets	Length [mm]	Width [mm]	Pitch [mm]
STQFN 18L 0.4P FC Green	18	1.6 x 3 x 0.55	3,000	3,000	178 / 60	100	400	100	400	8	4

Carrier Tape Drawing and Dimensions

Package Type	PocketBTM Length	PocketBTM Width	Pocket Depth	Index Hole Pitch	Pocket Pitch	Index Hole Diameter	Index Hole to Tape Edge	Index Hole to Pocket Center	Tape Width
	Α0	В0	K0	P0	P1	D0	E	F	w
STQFN 18L 0.4P FC Green	1.78	3.18	0.76	4	4	1.5	1.75	3.5	8



Recommended Reflow Soldering Profile

Please see IPC/JEDEC J-STD-020: latest revision for reflow profile based on package volume of 2.64 mm³ (nominal). More information can be found at www.jedec.org.

000-0059H1120-101 Page 18 of 19



Revision History

Date	Version	Change
10/03/2016	1.01	Fixed Chart on Page 6
8/25/2016	1.00	Production Release

000-0059H1120-101 Page 19 of 19